

Application/Control No.	Applicant(s)/Patent under Reexamination
10/639,059	THERIAULT, P. CHRIS
Examiner	Art Unit
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	SEAR	CHED	
Class	Subclass	Date	Examiner
359	883	4/6/2005	ММ
442		4/6/2005	ММ
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

	CH NOTES EARCH STRATEGY)	
	DATE	EXMR
EAST	4/6/2005	ММ
IDS	4/6/2005	MM
Science Direct	4/12/2005	MM
Carbon	4/12/2005	ММ
Google	4/12/2005	мм
PLUS	4/7/2005	мм